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N-channel 25 V 6.3 m Ω logic level MOSFET in LFPAK Rev. 2 — 22 December 2011 Product

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOSTM technology

1.2 Features and benefits

- Low thermal resistance
- Low threshold voltage

- Optimized for use in DC-to-DC converters
- Very low switching and conduction losses

1.3 Applications

- DC-to-DC convertors
- Notebook computers

- Switched-mode power supplies
- Voltage regulators

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	25	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	78.7	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	62.5	W
Static chara	Static characteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 9</u> ; see <u>Figure 10</u>	-	7.4	9.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 9</u> ; see <u>Figure 10</u>	-	4.7	6.3	mΩ
Dynamic ch	Dynamic characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; V_{DS} = 12 \text{ V}; \text{see}$	-	3.3	-	nC
$Q_{G(tot)}$	total gate charge	Figure 11; see Figure 12	-	13.3	-	nC



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2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source	mb	D
3	S	source		
4	G	gate		u———
mb	D	mounting base; connected to drain	1 2 3 4	mbb076 S

SOT669 (LFPAK; Power-SO8)

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
PH6325L	LFPAK; Power-SO8	plastic single-ended surface-mounted package; 4 leads	SOT669		

N-channel 25 V 6.3 m Ω logic level MOSFET in LFPAK

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		,			
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}$	-	25	٧
V_{GS}	gate-source voltage		-20	20	٧
I _D	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{Model}}$	-	49.6	Α
		$V_{GS} = 10 \text{ V}$; $T_{mb} = 25 \text{ °C}$; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	78.7	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$; see Figure 3	-	236	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	62.5	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-dr	ain diode				
Is	source current	T _{mb} = 25 °C	-	52	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	208	Α
Avalanche	ruggedness				
E _{DS(AL)R}	repetitive drain-source avalanche energy	t_p = 0.015 ms; unclamped; R_{GS} = 50 $\Omega;$ I_D = 3.4 A; $\;$ [1][2] $\;$ V $_{DD}$ = 25 V; V $_{GS}$ = 10 V	-	1.2	mJ
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 34 A; V_{DD} = 25 V; t_p = 0.15 ms; unclamped; R_{GS} = 50 Ω	-	115	mJ

- [1] Duty cycle is limited by the maximum junction temperature.
- [2] Repetitive avalanche failure is not determined simply by thermal effects. Repetitive avalanche transients should only be applied for short bursts, not every switching cycle.

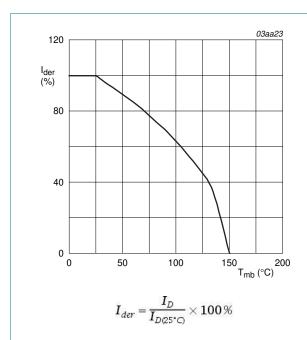


Fig 1. Normalized continuous drain current as a function of mounting base temperature

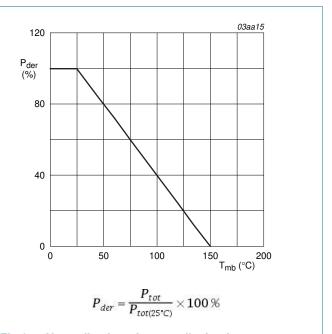


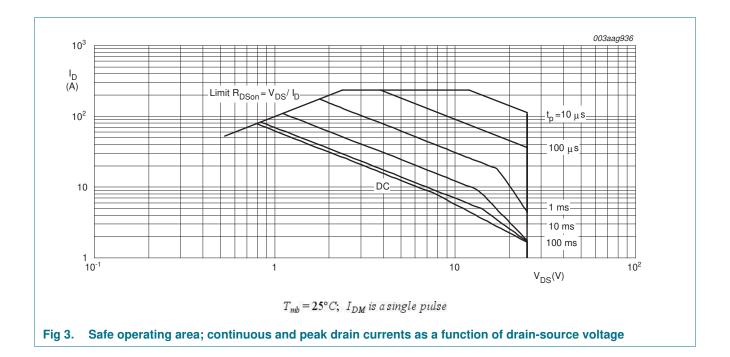
Fig 2. Normalized total power dissipation as a function of mounting base temperature

PH6325L

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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	2	K/W

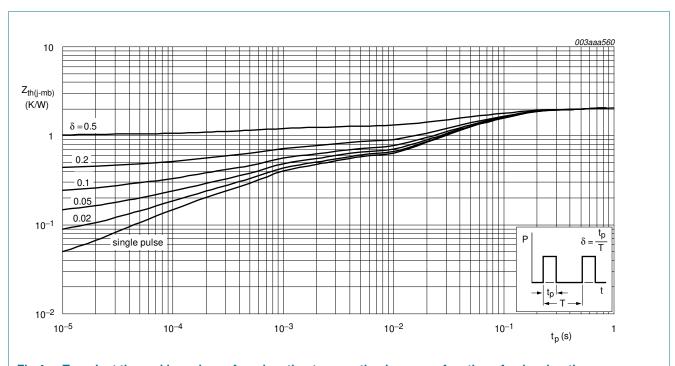


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

N-channel 25 V 6.3 mΩ logic level MOSFET in LFPAK

6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	25	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	2.2	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 150$ °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	0.5	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	1	1.5	2	V
I _{DSS}	drain leakage current	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.06	1	μΑ
		V _{DS} = 25 V; V _{GS} = 0 V; T _j = 150 °C	-	-	500	μΑ
lgss	gate leakage current	$V_{GS} = 16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 150 \text{ °C};$ see Figure 9; see Figure 10	-	7.5	10.1	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 150 °C; see Figure 9; see Figure 10	-	11.8	15.2	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 9</u> ; see <u>Figure 10</u>	-	7.4	9.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see Figure 9; see Figure 10	-	4.7	6.3	mΩ
R_{G}	internal gate resistance	f = 1 MHz	-	1.8	-	Ω
Dynamic o	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 25 \text{ A}$; $V_{DS} = 12 \text{ V}$; $V_{GS} = 4.5 \text{ V}$; see Figure 11; see Figure 12	-	13.3	-	nC
		$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 4.5 V$	-	11.1	-	nC
Q_{GS}	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 12 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	4.9	-	nC
Q _{GS1}	pre-threshold gate-source charge	see Figure 11; see Figure 12	-	2.6	-	nC
Q _{GS2}	post-threshold gate-source charge		-	2.3	-	nC
Q_{GD}	gate-drain charge		-	3.3	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 25 \text{ A}$; $V_{DS} = 12 \text{ V}$; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	2.4	-	V
C _{iss}	input capacitance	$V_{DS} = 0 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}$	-	2420	-	pF
		V _{DS} = 12 V; V _{GS} = 0 V; f = 1 MHz;	-	1871	-	рF
Coss	output capacitance	$T_j = 25 ^{\circ}\text{C}$; see <u>Figure 13</u> ;	-	517	-	pF
C _{rss}	reverse transfer capacitance	- see <u>Figure 14</u>	-	179	-	pF
d(on)	turn-on delay time	$V_{DS} = 12 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	25	-	ns
r	rise time	$R_{G(ext)} = 4.7 \Omega; I_D = 25 A$	-	25	-	ns
d(off)	turn-off delay time		-	32	-	ns
t _f	fall time		-	12	-	ns

N-channel 25 V 6.3 m Ω logic level MOSFET in LFPAK

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dra	ain diode					
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 15</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	33	-	ns
Qr	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}$	-	13	-	nC

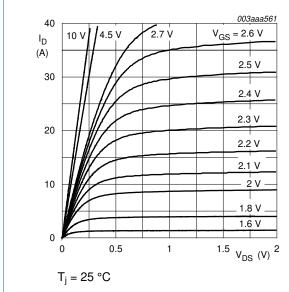


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

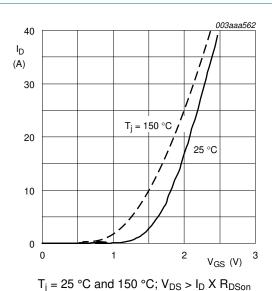


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

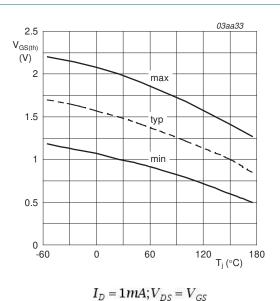


Fig 7. Gate-source threshold voltage as a function of junction temperature

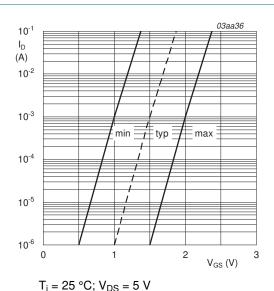


Fig 8. Sub-threshold drain current as a function of gate-source voltage

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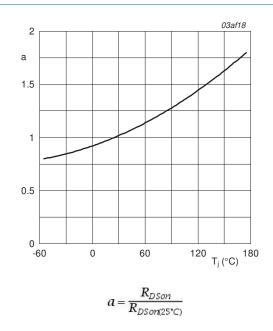


Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature

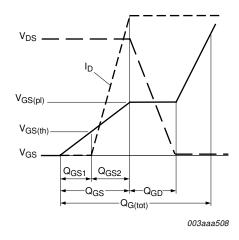


Fig 11. Gate charge waveform definitions

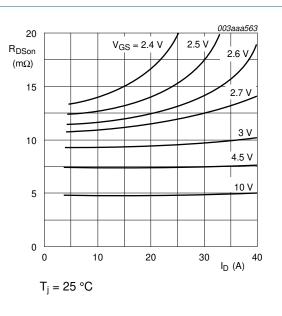
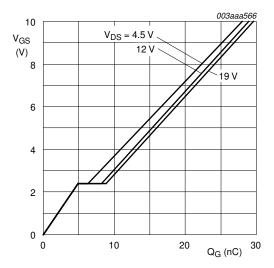


Fig 10. Drain-source on-state resistance as a function of drain current; typical values



 I_D = 25 A; V_{DS} = 4.5 V, 12 V and 19 V

Fig 12. Gate-source voltage as a function of gate charge; typical values

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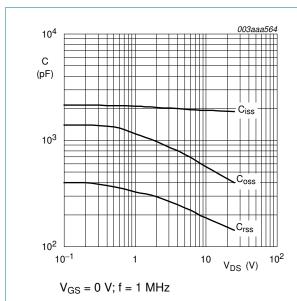
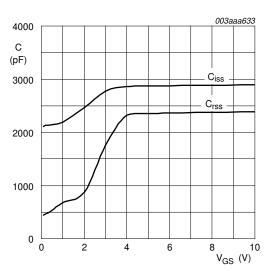
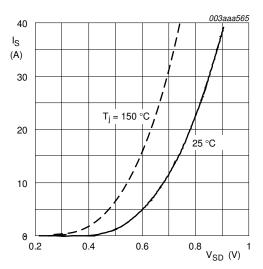


Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $T_i = 25$ °C and 150 °C; $V_{DS} = 0$ V

Fig 14. Input and reverse transfer capacitances as a function of gate-source voltage; typical values



 $T_i = 25$ °C and 150 °C; $V_{GS} = 0$ V

Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

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N-channel 25 V 6.3 mΩ logic level MOSFET in LFPAK

Package outline

Plastic single-ended surface-mounted package (LFPAK; Power-SO8); 4 leads

SOT669

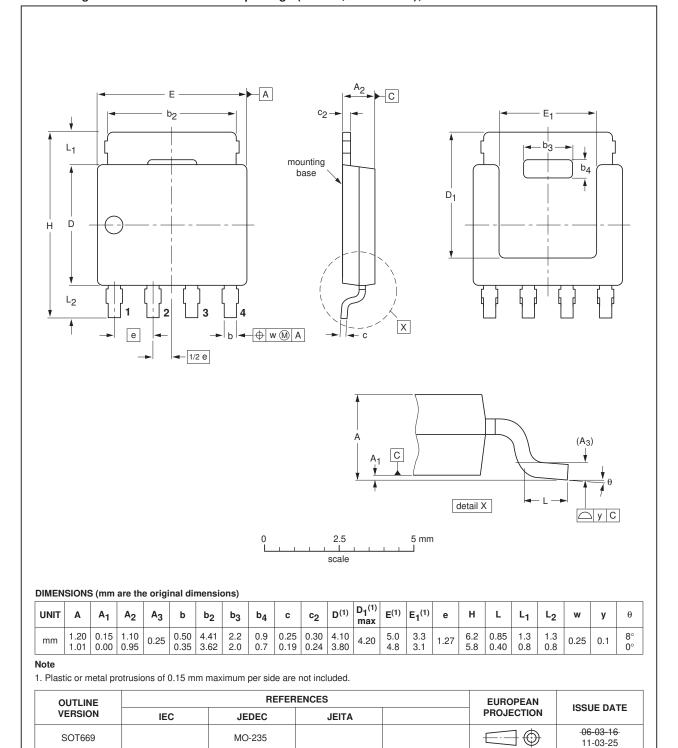


Fig 16. Package outline SOT669 (LFPAK; Power-SO8)

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N-channel 25 V 6.3 mΩ logic level MOSFET in LFPAK

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PH6325L v.2	20111222	Product data sheet	-	PH6325L v.1
Modifications:	 The format of this document has been redesigned to comply with the new identity guidelin NXP Semiconductors. 			
	 Legal texts have 	ve been adapted to the new	company name where	appropriate.
	 Status change 	d from preliminary to produc	ot.	
PH6325L v.1	20040428	Preliminary data shee	t -	-

N-channel 25 V 6.3 mΩ logic level MOSFET in LFPAK

9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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